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Form PTO-1449		US Dept. of Commerce PATENT & THADEMARK OFFICE		ATTY DOCKET NO. D/A058		APPLICATION NO.	
1		N DISCLOSURE STATEM	ENT	APPLICANT Ralph A! Mosher et al			
(Use several sheets if necessary)			FILING		TE Herewith	GROUP ART UNIT	
			U.S. PAT	ENT DOCU	MENTS		
XAMINER NITIAL		CUMENT NUMBER	PUBLICATI DATE	ION	NAME OF PATENTEE	CLAS	SUB CLASS
12		6,096,927	8/1/00)	Satish R. Parikh et al	564	434
1		6,099,996	8/8/00)	John F. Yanus et al	430	58.8
		6,099,997	8/8/00)	David Terrell et al	430	59.1
		6,130,024	10/10/0	00	Peter T. Aylward et al	430	256
	/	6,136,484	10/24/0	00	Satoshi Katayama et al	430	63
V		6,174,635 B1		1	David Terrell et al	430	56
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			FOREIGN F	PATENT DO	CUMENTS		
	COUNTRY			ICATION NAME OF PATENTEE C		PLICANT	TRANSLATION Y/N
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	ОТ	HER DOCUMENTS (Include	ling Author (in C	CAPS), Title,	Publication Date, Pages, etc.)		

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